

<b>Notice of References Cited</b>	Application/Control No. 10/674,806	Applicant(s)/Patent Under Reexamination RAPACKI ET AL.	
	Examiner EDMUND H. LEE	Art Unit 1732	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,689,160	02-2004	Okuda et al.	623/1.39
*	B	US-2,127,903	08-1938	ARTHUR BOWEN	606/154
*	C	US-5,152,782	10-1992	Kowligi et al.	623/1.46
*	D	US-3,042,021	07-1962	THANE READ	128/843
*	F	US-6,007,576	12-1999	McClellan, Scott B.	623/23.64
*	F	US-7,022,134	04-2006	Quijano et al.	623/1.24
*	G	US-5,643,340	07-1997	Nunokawa, Mioko	623/1.49
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.